7N50-MTQ Preliminary Power MOSFET

# 7.0A, 500V N-CHANNEL POWER MOSFET

# **■** DESCRIPTION

The UTC **7N50-MTQ** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

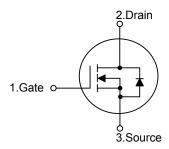
The UTC 7N50-MTQ is generally applied in high efficiency switch mode power supplies.



<sup>\*</sup>  $R_{DS(ON)}$  < 0.87 $\Omega$  @  $V_{GS}$  = 10 V,  $I_{D}$  = 3.5 A

# 1 TO-252

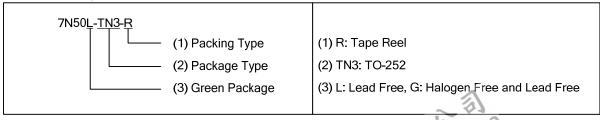
### ■ SYMBOL



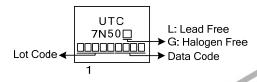
### ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7N50L-TN3-R	7N50G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



# **■** MARKING



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<sup>\*</sup> High Switching Speed

# ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{DSS}$	500	V	
Gate-Source Voltage		$V_{GSS}$	±30	V	
Drain Current	Continuous	T <sub>C</sub> =25°C	I <sub>D</sub>	7	Α
	Pulsed (Note 2)		I <sub>DM</sub>	28	Α
Avalanche Energy	Single Pulsed (Note 3)		E <sub>AS</sub>	270	mJ
Power Dissipation (T <sub>C</sub> =25°C)		0	39	W	
Derate above 25°C		P <sub>D</sub>	3.2	W/°C	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T <sub>STG</sub>	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 10mH,  $I_{AS}$  = 7A,  $V_{DD}$  = 50V,  $R_G$  = 25 $\Omega$ , Starting  $T_J$  = 25 $^{\circ}$ C
- 4.  $I_{SD} \le 7A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

# **■ THERMAL RESISTANCES CHARACTERISTICS**

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	62.5	°C/W	
Junction to Case	$\theta_{JC}$	3.2	°C/W	

### **■ ELECTRICAL CHARACTERISTICS**

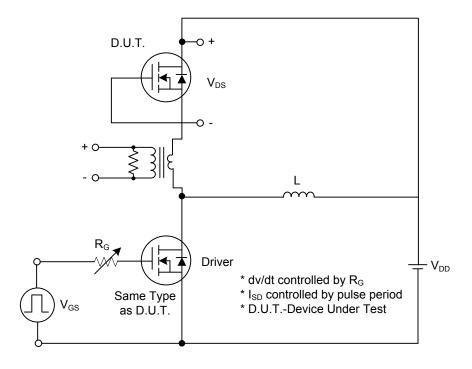
PARAMETER		SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	500			V	
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	Reference to 25°C, I <sub>D</sub> =250µA		0.5		V/°C	
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =500V, V <sub>GS</sub> =0V			10	μΑ	
Gate- Source Leakage Current	Forward	$I_{GSS}$	$V_{GS}$ =+30V, $V_{DS}$ =0V			+100	nA	
	Reverse	IGSS	$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0		4.0	V	
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3.5A			0.87	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		$C_{ISS}$			750		pF	
Output Capacitance		Coss	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz		130		pF	
Reverse Transfer Capacitance		$C_{RSS}$			16		pF	
SWITCHING PARAMETERS								
Turn-ON Delay Time		t <sub>D(ON)</sub>			55		ns	
Rise Time		$t_R$	$V_{DS}$ =30V, $I_{D}$ =0.5A, $R_{G}$ =25 $\Omega$		43		ns	
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	(Note 1, 2)		210		ns	
Fall-Time		$t_{F}$			40		ns	
Total Gate Charge at 10V		$Q_{G(TOT)}$	V <sub>GS</sub> =10V, V <sub>DS</sub> =50V, I <sub>D</sub> =1.3A		90		nC	
Gate to Source Charge		$Q_GS$	(Note 1, 2)		6.5		nC	
Gate to Drain Charge		$Q_GD$	(Note 1, 2)		7.5		nC	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is	I BR COIL			7	Α	
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>	1 18 28.			28	Α	
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>SD</sub> =7A, V <sub>GS</sub> =0V			1.4	V	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

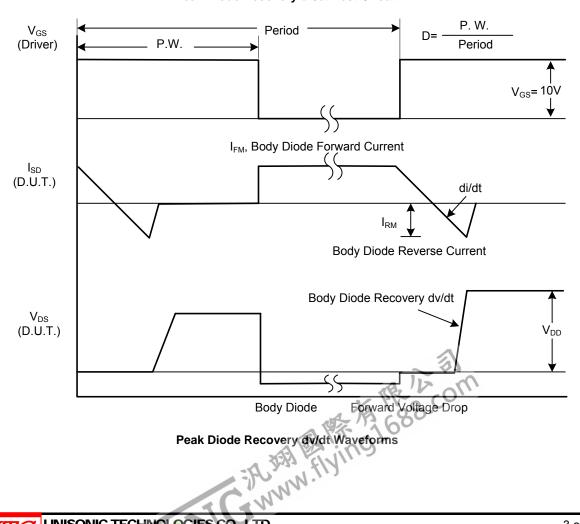
2. Essentially Independent of Operating Temperature Typical Characteristics



# **TEST CIRCUITS AND WAVEFORMS**

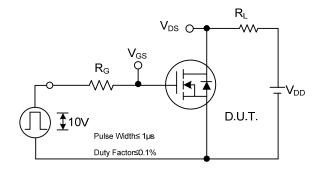


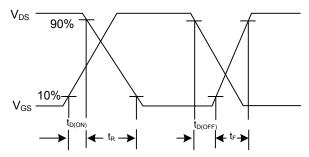
# Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

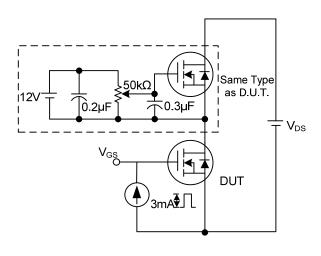
# **TEST CIRCUITS AND WAVEFORMS (Cont.)**

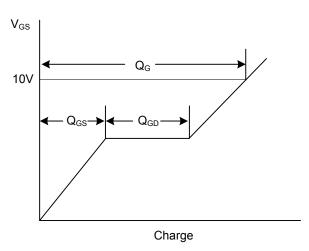




**Switching Test Circuit** 

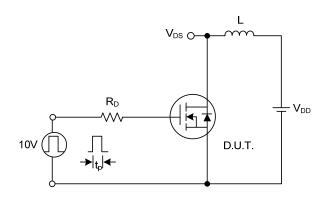
**Switching Waveforms** 

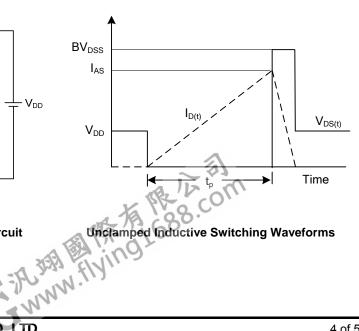




**Gate Charge Test Circuit** 

**Gate Charge Waveform** 





**Unclamped Inductive Switching Test Circuit** 

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